# MOSFET – Power, N-Channel with ESD Protection, SOT-723 20 V, 285 mA

#### **Features**

- Enables High Density PCB Manufacturing
- 44% Smaller Footprint than SC-89 and 38% Thinner than SC-89
- Low Voltage Drive Makes this Device Ideal for Portable Equipment
- Low Threshold Levels,  $V_{GS(TH)} < 1.3 \text{ V}$
- Low Profile (< 0.5 mm) Allows It to Fit Easily into Extremely Thin Environments such as Portable Electronics
- Operated at Standard Logic Level Gate Drive, Facilitating Future Migration to Lower Levels Using the Same Basic Topology
- These are Pb-Free and Halogen-Free Devices

#### **Applications**

- Interfacing, Switching
- High Speed Switching
- Cellular Phones, PDAs

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	20	V
Gate-to-Source Voltag	Gate-to-Source Voltage			±10	V
Continuous Drain	Steady	T <sub>A</sub> = 25°C		255	
Current (Note 1)	State	T <sub>A</sub> = 85°C	I <sub>D</sub>	185	mA
	t ≤ 5 s	T <sub>A</sub> = 25°C		285	
Power Dissipation (Note 1)	Steady State	,		440	mW
	t ≤ 5 s	.,	P <sub>D</sub>	545	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	210	A
Current (Note 2)	Steady	T <sub>A</sub> = 85°C		155	mA
Power Dissipation (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	310	mW
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	400	mA
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode) (Note 2)			IS	286	mA
Lead Temperature for Soldering Purposes (1/8" from case for 10 seconds)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

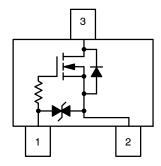


#### ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> Max	
	1.5 Ω @ 4.5 V		
20 V	2.4 Ω @ 2.5 V	285 mA	
20 V	5.1 Ω @ 1.8 V	200 1117	
	6.8 Ω @ 1.65 V		

#### Top View



- 1 Gate
- 2 Source
- 3 Drain

SOT-723 CASE 631AA STYLE 5

#### MARKING DIAGRAM



KA = Device Code
M = Date Code

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTK3043NT1G	SOT-723*	4000 / Tape & Reel
NTK3043NT5G	SOT-723*	8000 / Tape & Reel

- †For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.
- \*These packages are inherently Pb-Free.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	280	
Junction-to-Ambient - t = 5 s (Note 3)	$R_{\theta JA}$	228	°C/W
Junction-to-Ambient - Steady State Minimum Pad (Note 4)	$R_{ heta JA}$	400	

- 3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Test Condition		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	$V_{GS}$ = 0 V, $I_D$ = 100 $\mu A$		V <sub>(BR)DSS</sub>	20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$I_D$ = 100 $\mu$ A, Reference to 25°C		V <sub>(BR)DSS</sub> /T <sub>J</sub>		27		mV/°C
Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C	I <sub>DSS</sub>			1	
	$V_{DS} = 16 V$	T <sub>J</sub> = 125°C				10 μ	μΑ
Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	<sub>S</sub> = ±5 V	I <sub>GSS</sub>			1	μΑ
ON CHARACTERISTICS (Note 3)							•
Gate Threshold Voltage	., ., .		V <sub>GS(TH)</sub>	0.4		1.3	V
Gate Threshold Temperature Coefficient	$V_{GS} = V_{DS}, I_{D} = I_{CS}$	= 250 μΑ	V <sub>GS(TH)</sub> /T <sub>J</sub>		-2.4		mV/°C
Drain-to-Source On Resistance	V <sub>GS</sub> = 4.5V, I <sub>D</sub>	= 10 mA	R <sub>DS(ON)</sub>		1.5	3.4	
	V <sub>GS</sub> = 4.5V, I <sub>D</sub> =	= 255 mA	_		1.6	3.8	
	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1 mA		_		2.4	4.5	Ω
	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 1 mA		_		5.1	10	
	V <sub>GS</sub> = 1.65 V, I <sub>D</sub> = 1 mA		_		6.8	15	
Forward Transconductance	$V_{DS} = 5 \text{ V}, I_D = 100 \text{ mA}$		9FS		0.275		S
Gate Resistance	T <sub>A</sub> = 25°C		$R_{G}$		2.2		kΩ
CHARGES, CAPACITANCES AND GAT	E RESISTANCE						
Input Capacitance			C <sub>ISS</sub>		11		
Output Capacitance	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 10 V		C <sub>OSS</sub>		8.3		pF
Reverse Transfer Capacitance			C <sub>RSS</sub>		2.7		
SWITCHING CHARACTERISTICS, VGS	G= <b>4.5 V</b> (Note 4)						
Turn-On Delay Time			t <sub>d(ON)</sub>		13		
Rise Time	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 5	V, I <sub>D</sub> = 10 mA,	t <sub>r</sub>		15		
Turn-Off Delay Time	$R_{G} = 6 \Omega$		t <sub>d(OFF)</sub>		94		ns
Fall Time			t <sub>f</sub>		55		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V 0VI 000 × A	T <sub>J</sub> = 25°C	$V_{SD}$		0.83	1.2	V
	$V_{GS} = 0 \text{ V, } I_{S} = 286 \text{ mA}$ $T_{J} = 125^{\circ}\text{C}$				0.69		\ \
Reverse Recovery Time	$V_{GS}$ = 0 V, $V_{DD}$ = 20 V, dISD/dt = 100 A/ $\mu$ s, $I_{S}$ = 286 mA		t <sub>RR</sub>		9.1		
Charge Time			t <sub>a</sub>		7.1		ns
Discharge Time			t <sub>b</sub>		2.0		7
Reverse Recovery Charge			Q <sub>RR</sub>		3.7		nC

- 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%
- 6. Switching characteristics are independent of operating junction temperatures

#### **TYPICAL PERFORMANCE CURVES**

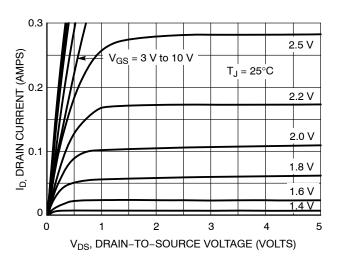


Figure 1. On-Region Characteristics

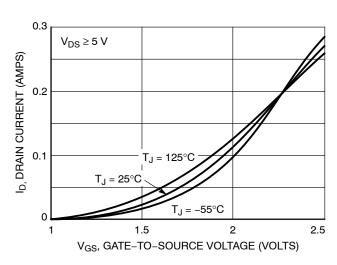


Figure 2. Transfer Characteristics

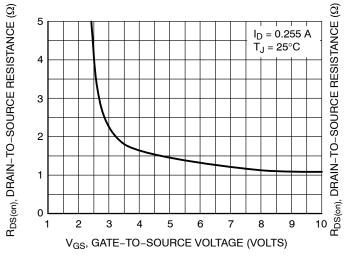


Figure 3. On-Resistance vs. Gate-to-Source Voltage

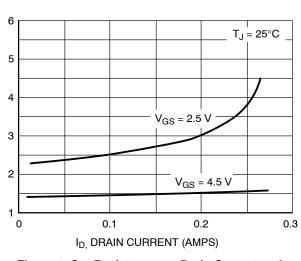


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

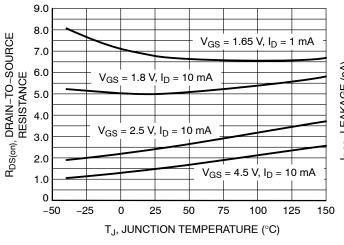


Figure 5. On–Resistance Variation with Temperature

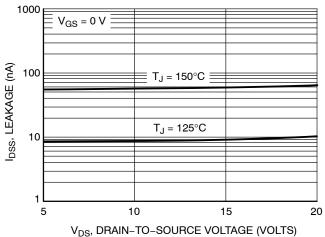
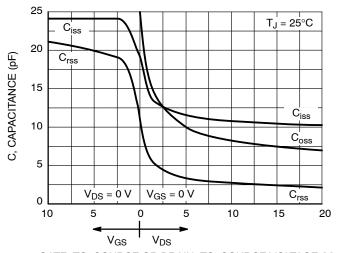


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

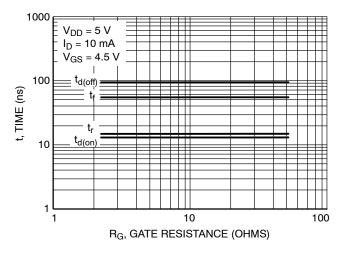


Figure 8. Resistive Switching Time Variation vs. Gate Resistance

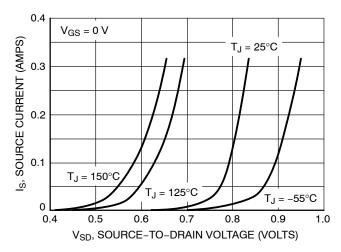


Figure 9. Diode Forward Voltage vs. Current



SOT-723 CASE 631AA-01 ISSUE D

**DATE 10 AUG 2009** 

# NOTES:

- NOTES.

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: MILLIMETERS.

  3. MAXIMUM LEAD THICKNESS INCLUDES LEAD
- FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.45	0.50	0.55	
b	0.15	0.21	0.27	
b1	0.25	0.31	0.37	
С	0.07	0.12	0.17	
D	1.15	1.20	1.25	
E	0.75	0.80	0.85	
е	0.40 BSC			
ΗE	1.15	1.20	1.25	
L	0.29 REF			
12	0.15	0.20	0.25	

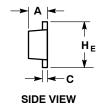
### **L2** 0.15 0.20 0.25 **GENERIC** MARKING DIAGRAM\*

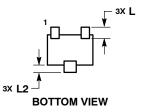


= Specific Device Code XX Μ = Date Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

# -X-2X b ⊕ 0.08 X Y **TOP VIEW**

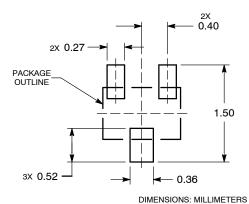




STYLE 1: PIN 1. BASE 2. EMITTER 3. COLLECTOR STYLE 2: PIN 1. ANODE 2. N/C 3. CATHODE STYLE 3: PIN 1. ANODE 2. ANODE 3. CATHODE

STYLE 4: PIN 1. CATHODE 2. CATHODE 3. ANODE STYLE 5: PIN 1. GATE 2. SOURCE 3. DRAIN

**RECOMMENDED SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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